

**General Description**

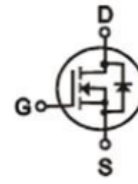
It combines advanced trench MOSFET technology with a low resistance package to provide extremely low  $R_{DS(ON)}$ . This device is ideal for load switch and battery protection applications.

**Features**

- Advance high cell density Trench technology
- Low  $R_{DS(ON)}$  to minimize conductive loss
- Low Gate Charge for fast switching
- Low Thermal resistance
- Wettable Flanks

**Application**

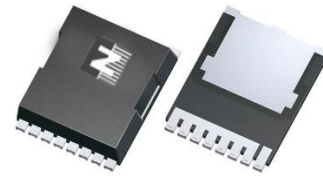
- SMPS 2<sup>nd</sup> Synchronous Rectifier
- POL application
- BLDC Motor driver

**Product Summary**

$V_{DS} = 30V$

$R_{DS(ON)} = 1.0m\Omega$

$I_D = 304A$



TOLL

**Ordering Information:**

Part NO.	ZMS006N03R
Marking	ZMS006N03
Packing Information	REEL TAPE
Basic ordering unit (pcs)	800

**Absolute Maximum Ratings (T<sub>C</sub>=25°C)**

Parameter	Symbol	Rating	Unit
Drain-Source Voltage	$V_{DS}$	30	V
Gate-Source Voltage	$V_{GS}$	±20	V
Continuous Drain Current	$I_D @ T_C=25^\circ C$	304 <sup>①</sup>	A
	$I_D @ T_C=75^\circ C$	258	A
	$I_D @ T_C=100^\circ C$	191	A
Pulsed Drain Current <sup>②</sup>	$I_{DM}$	912	A
Total Power Dissipation	$P_D @ T_C=25^\circ C$	250	W
Total Power Dissipation <sup>③</sup>	$P_D @ T_A=25^\circ C$	4.2	W
Operating Junction Temperature	$T_J$	-55 to 150	°C
Storage Temperature	$T_{STG}$	-55 to 150	°C
Single Pulse Avalanche Energy (L=0.5mH, VGS=10V, Rg=25Ω, TJ=25)	$E_{AS}$	1120	mJ
Single Pulse Avalanche Energy (L=0.1mH, VGS=10V, Rg=25Ω, TJ=25)	$E_{AS}$	450	mJ



### •Thermal resistance

Parameter	Symbol	Min.	Typ.	Max.	Unit
Thermal resistance, junction - case	$R_{thJC}$	-	-	0.5	$^{\circ}C/W$
Thermal resistance, junction - ambient	$R_{thJA}$	-	-	30	$^{\circ}C/W$
Soldering temperature, wave soldering for 10s	$T_{sold}$	-	-	265	$^{\circ}C$

### •Electronic Characteristics

Parameter	Symbol	Condition	Min.	Typ	Max.	Unit
Drain-Source Breakdown Voltage	$BV_{DSS}$	$V_{GS}=0V, I_D=250\mu A$	30			V
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{GS}=V_{DS}, I_D=250\mu A$	1.2		2.5	V
Drain-Source Leakage Current	$I_{DSS}$	$V_{DS}=30V, V_{GS}=0V$			1.0	$\mu A$
Gate- Source Leakage Current	$I_{GSS}$	$V_{GS}=\pm 20V, V_{DS}=0V$			$\pm 100$	nA
Static Drain-source On Resistance	$R_{DS(ON)}$	$V_{GS}=10V, I_D=100A$		1.0	1.3	m $\Omega$
		$V_{GS}=4.5V, I_D=70A$		1.6	2.1	m $\Omega$
Forward Transconductance	$g_{FS}$	$V_{DS}=25V, I_D=100A$		32		S
Source-drain voltage	$V_{SD}$	$I_S=24A$			1.28	V

### •Dynamic Characteristics

Parameter	Symbol	Condition	Min.	Typ	Max.	Unit
Input capacitance	$C_{iss}$	$f = 1MHz,$ $V_{DS}=25V$	-	6558	-	pF
Output capacitance	$C_{oss}$		-	1354	-	
Reverse transfer capacitance	$C_{rss}$		-	121	-	
Gate Resistance	$R_g$	$f = 1MHz$		2.2		$\Omega$
Total gate charge	$Q_g$	$V_{DD}=20V$ $I_D=20A$ $V_{GS}=10V$	-	114	-	nC
Gate - Source charge	$Q_{gs}$		-	11	-	
Gate - Drain charge	$Q_{gd}$		-	33	-	
Turn-ON Delay time	$t_{D(on)}$	$V_{GS}=10V,$ $V_{DS}=15V$ $R_G=6\Omega,$ $I_D=25A$		26		ns
Turn-ON Rise time	$t_r$			27		ns
Turn-Off Delay time	$t_{D(off)}$			68		ns
Turn-Off Fall time	$t_f$			16		ns
Reverse Recovery Time	$t_{RR}$	$V_{DD}=20V,$ $dI_S/dt=100$ $A/s, I_S=30A$		68		ns
Charge Time	$t_a$			25		ns
Discharge Time	$t_b$			29		ns
Reverse Recovery Charge	$Q_{RR}$			98		nC



Fig.1 Power Dissipation

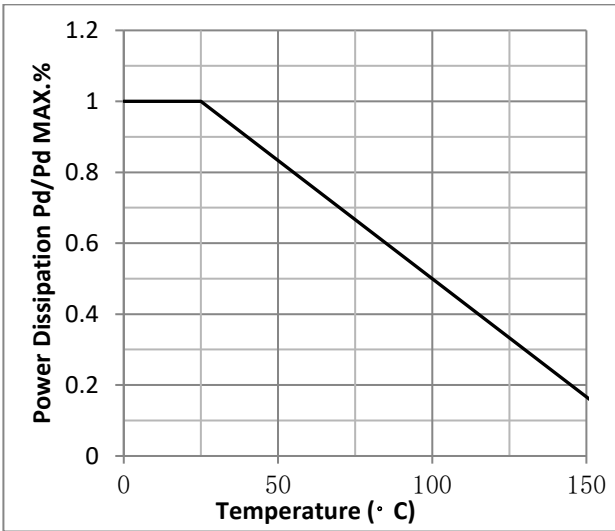


Fig.2 Typical output Characteristics

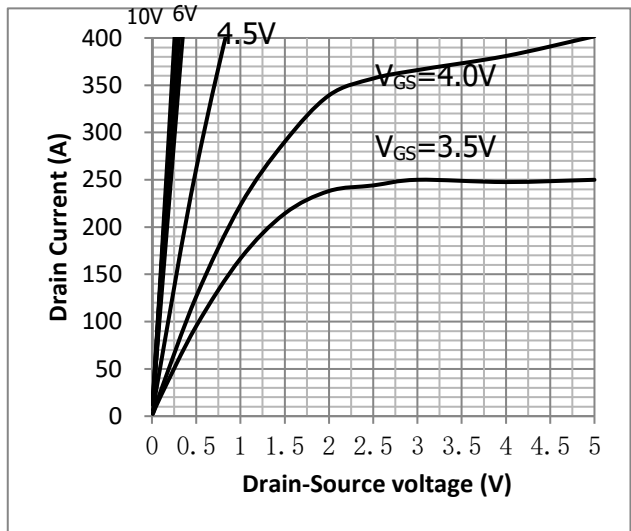


Fig.3 Threshold Voltage V.S Junction Temperature

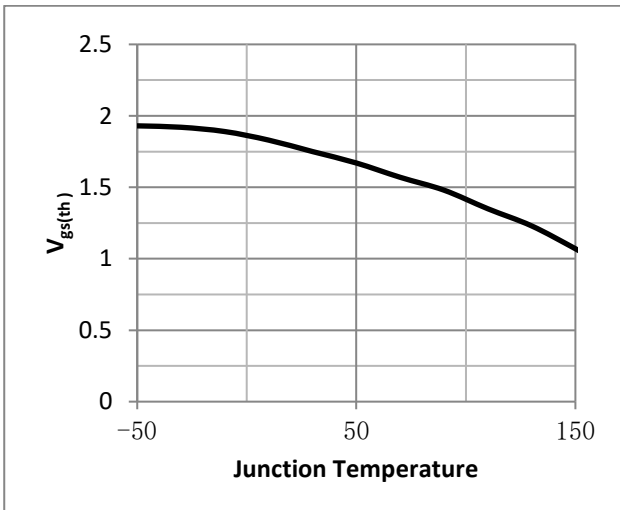


Fig.4 Resistance V.S Drain Current

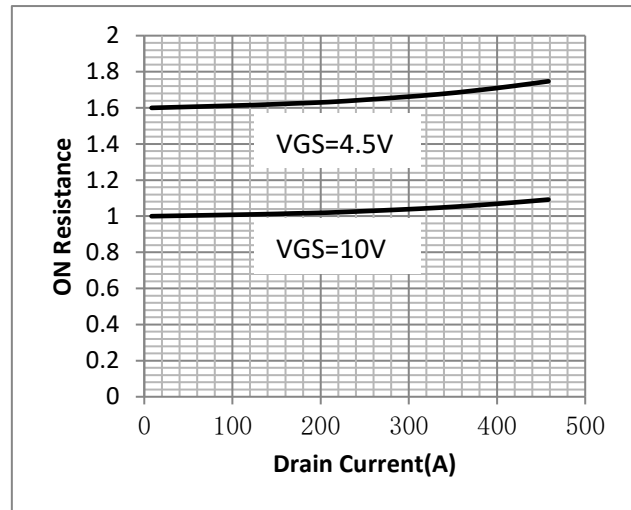


Fig.5 On-Resistance VS Gate Source Voltage

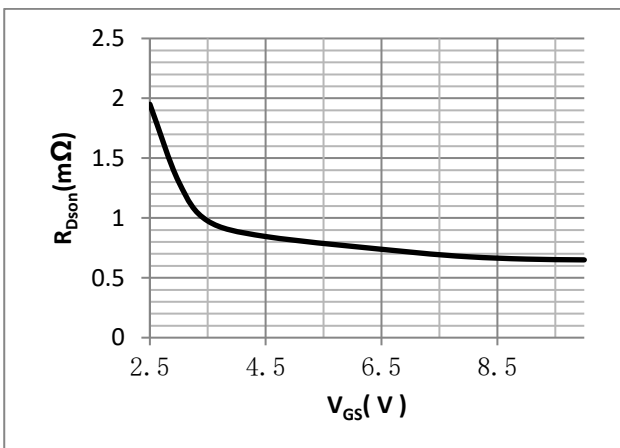


Fig.6 On-Resistance V.S Junction Temperature

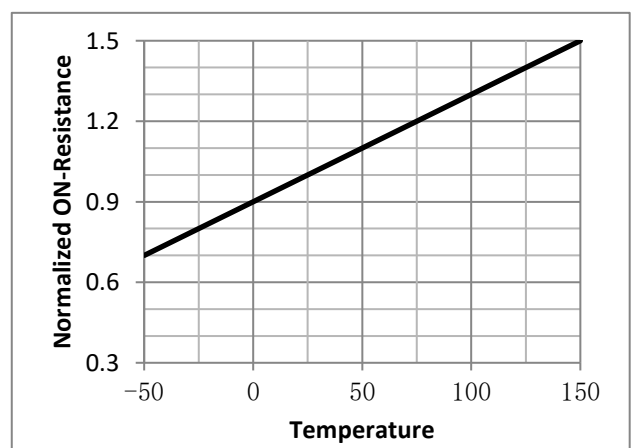




Fig.7 Gate Charge Characteristics

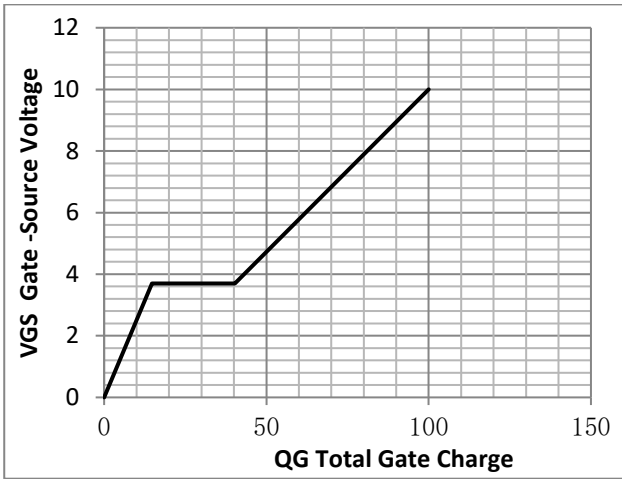


Fig.8 Capacitance vs Vds

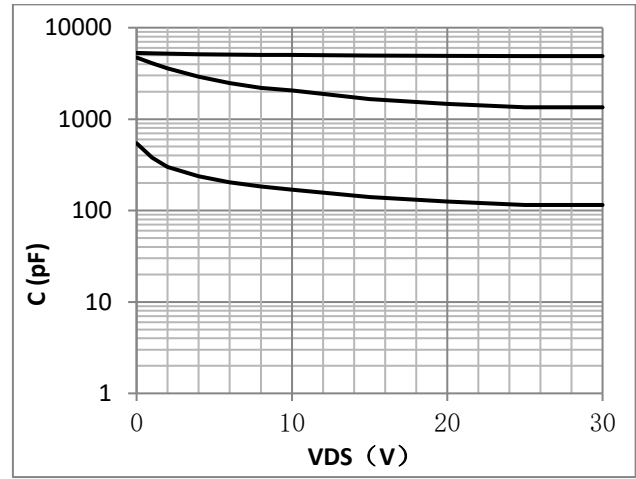


Fig.9 Diode Forward Voltage vs. Current

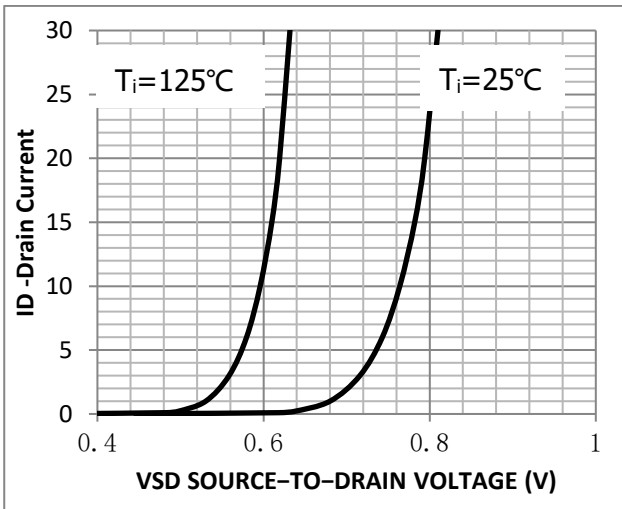


Fig.10 Capacitance Variation

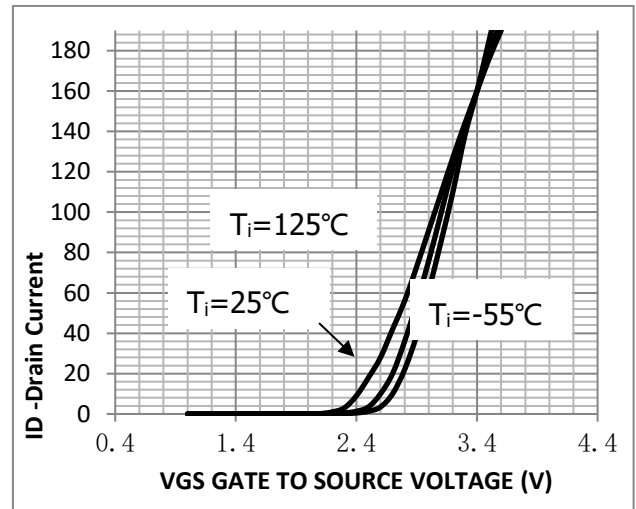


Fig.11 SOA Maximum Safe Operating Area

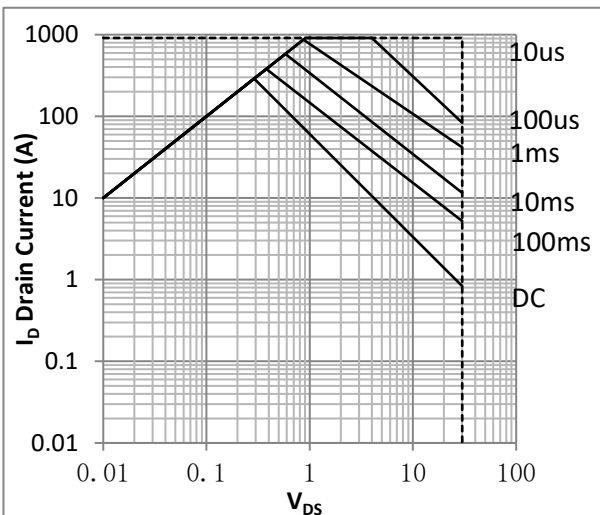


Fig.12 ID-Junction Temperature

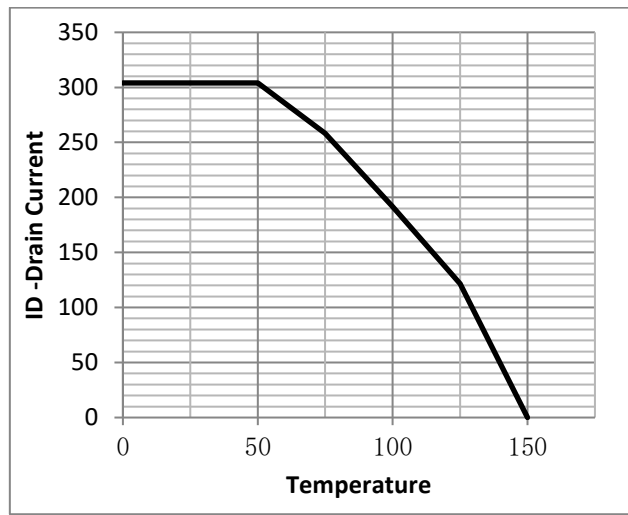




Fig.13 Normalized Maximum Transient Thermal Impedance

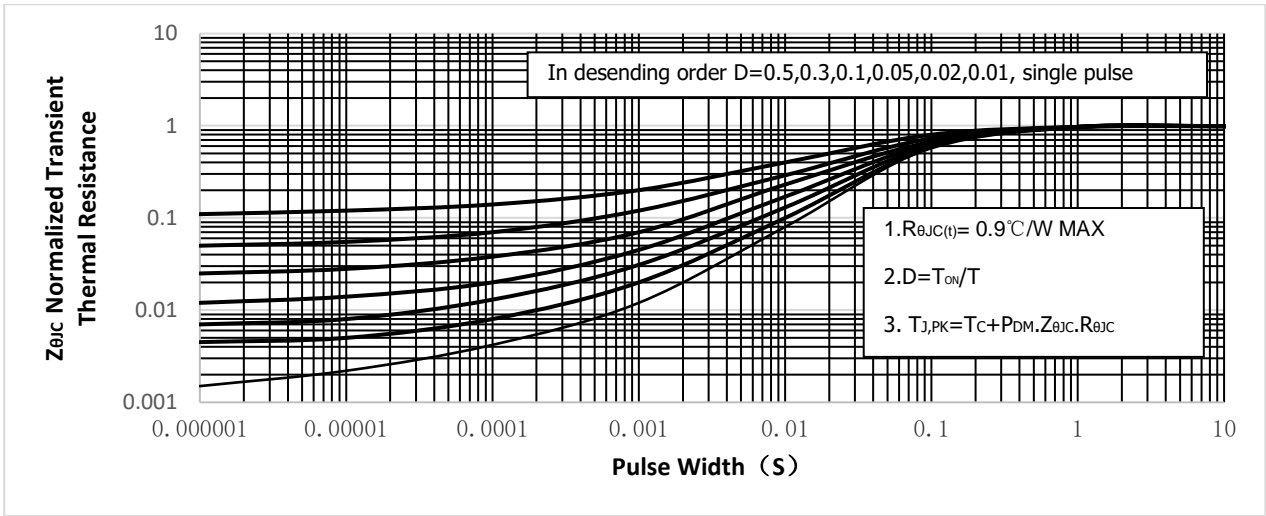


Fig.14 Switching Time Measurement Circuit

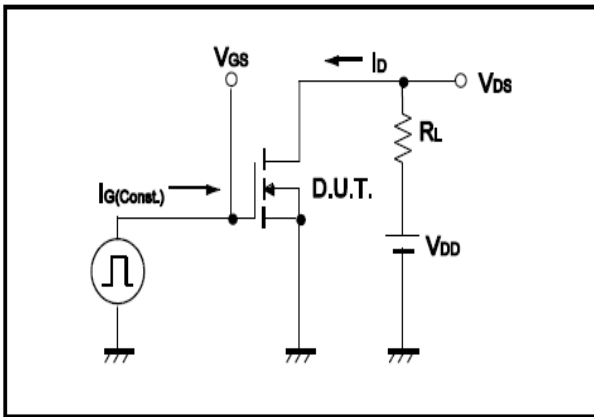


Fig.15 Gate Charge Waveform

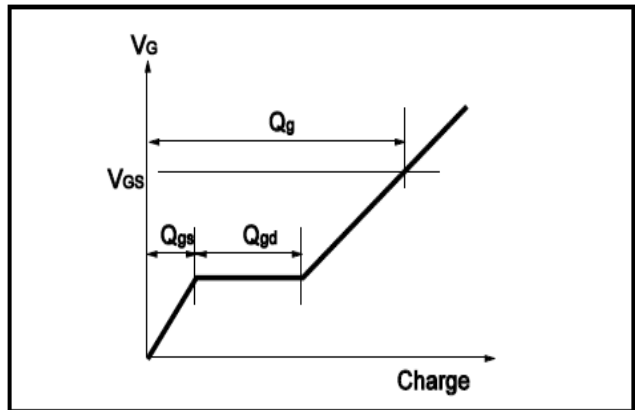


Fig.16 Resistive Switching Test Circuit

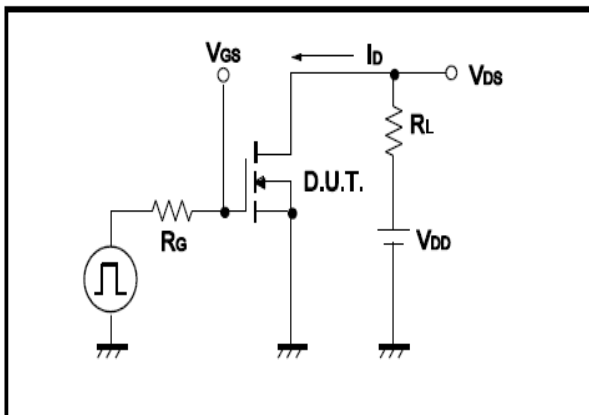


Fig.17 Resistive Switching Test Waveform

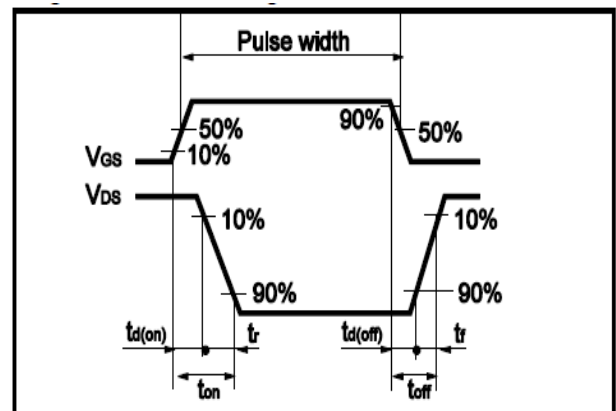




Fig.18 Avalanche Measurement Circuit

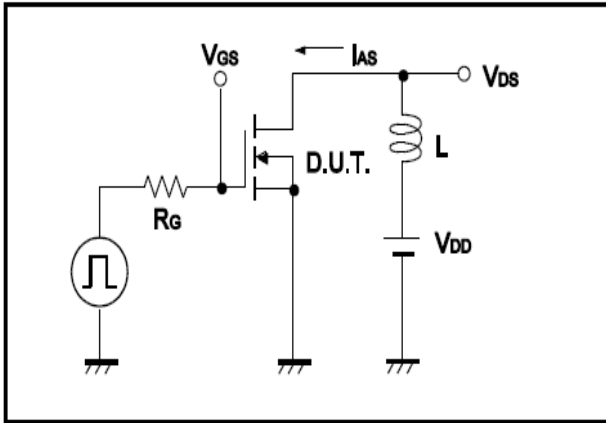
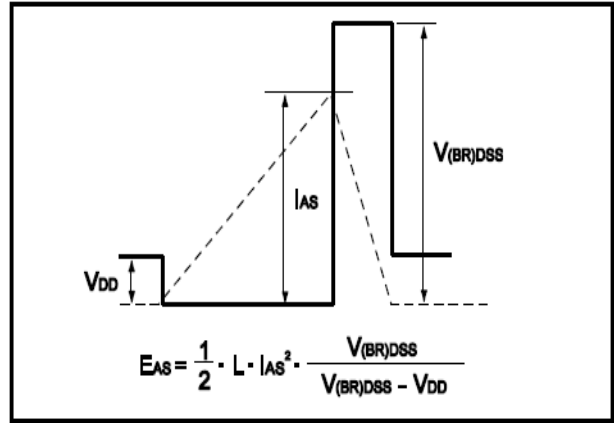


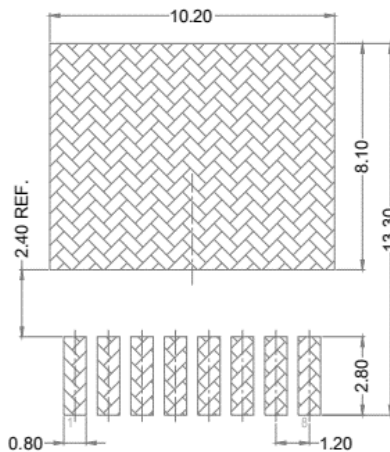
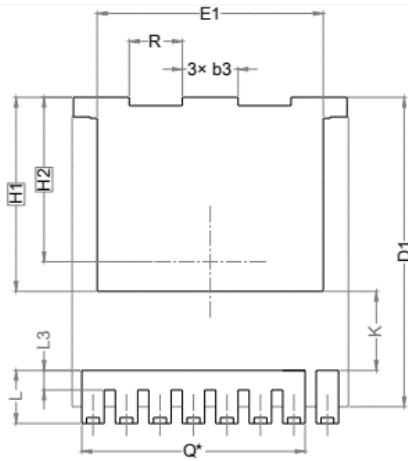
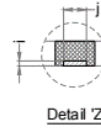
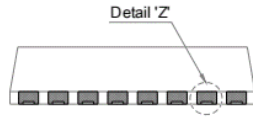
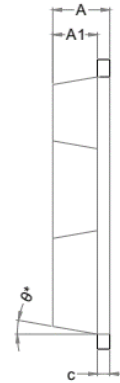
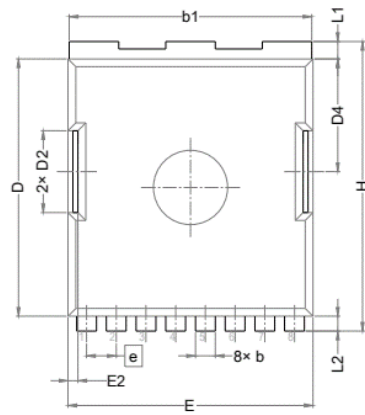
Fig.19 Avalanche Waveform





•Dimensions (TOLL)

Unit: mm



SYMBOL	DIMENSIONS		
	MIN.	NOM.	MAX.
A	2.20	2.30	2.40
A1	1.70	1.80	1.90
b	0.70	0.80	0.90
b1	9.70	9.80	9.90
b3	1.90	2.00	2.10
c	0.40	0.50	0.60
D	10.28	10.38	10.48
D1	10.98	11.08	11.18
D2	3.20	3.30	3.40
D4	4.45	4.55	4.65
E	9.80	9.90	10.00
E1	8.00	8.10	8.20
E2	0.30	0.40	0.50
e	1.20 BSC		
H	11.58	11.68	11.78
H1	6.95 BSC		
H2	5.89 BSC		
i	0.10 REF.		
j	0.46 REF.		
K	2.80 REF.		
L	1.60	1.90	2.10
L1	0.60	0.70	0.80
L2	0.50	0.60	0.70
L3	0.60	0.70	0.80
N	8		
Q	6.80 REF.		
R	1.80	1.90	2.00
theta	10° REF.		



Note:

- ① Limited by bonding wire
- ② Pulse Test : Pulse width  $\leq 300\mu\text{s}$ , Duty cycle  $\leq 2\%$  ;
- ③ Device mounted on FR-4 substrate PC board, 2oz copper, with thermal bias to bottom layer 1inch square copper plate;